

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC4015BP, TC4015BF, TC4015BFN

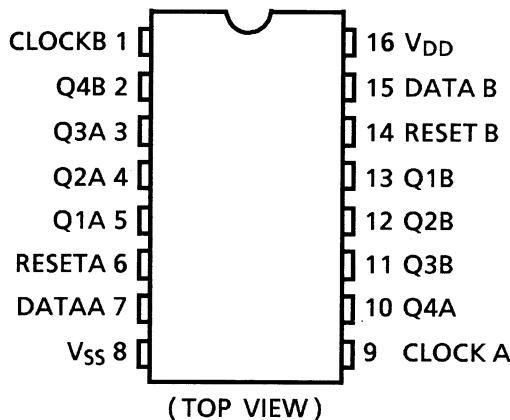
## TC4015B Dual 4-Stage Static Shift Register (with serial input/parallel output)

TC4015B contains two circuits of 4 stage shift registers and the independent output is driven from each stage. As all the D type flip-flops of every stage have common RESET input, asynchronous clear operation can be achieved by an external signal at arbitrary timing. The flip-flop of each stage is triggered by rising edge of CLOCK input.

RESET input of "H" level resets the contents of all the stages to "L" regardless of CLOCK and DATA inputs and all of data outputs Q1 through Q4 become "L".

This can be used for converting serial data to parallel one and for ring counters of any numbering systems.

### Pin Assignment



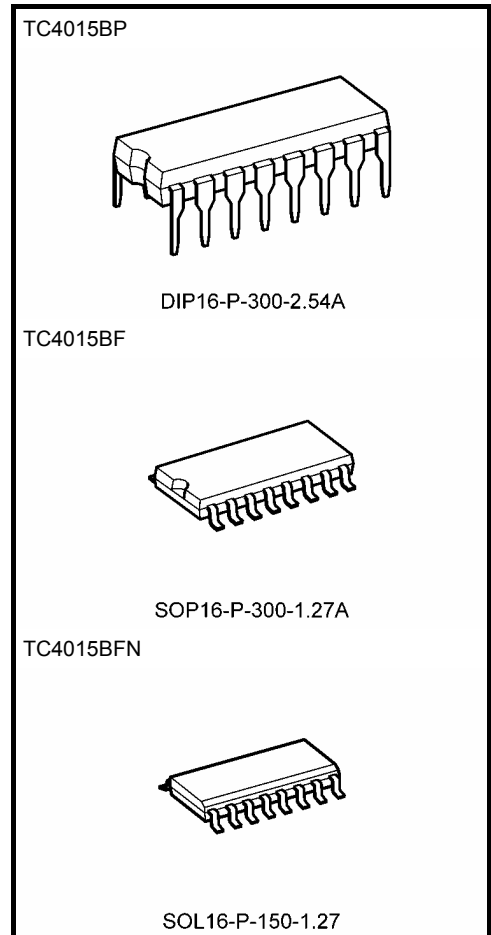
### Truth Table

Inputs			Outputs			
CLOCK $\Delta$	DATA	RESET	Q1	Q2	Q3	Q4
	L	L	L	Q1	Q2	Q3
	H	L	H	Q1	Q2	Q3
	*	L	No Change			
*	*	H	L	L	L	L

$\Delta$ : Level change

\*: Don't care

Note: xxxFN (JEDEC SOP) is not available in Japan.

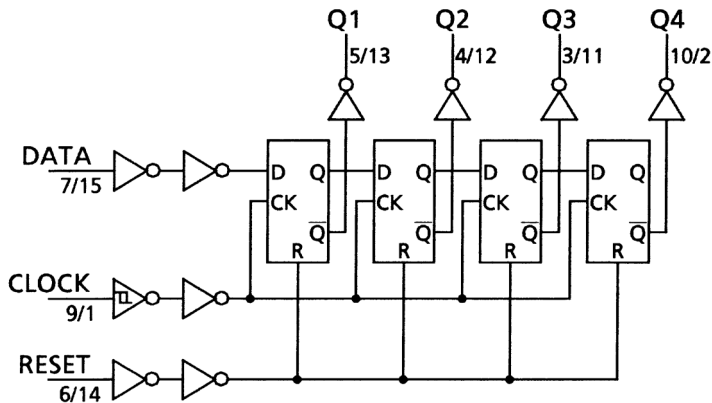


### Weight

DIP16-P-300-2.54A	: 1.00 g (typ.)
SOP16-P-300-1.27A	: 0.18 g (typ.)
SOL16-P-150-1.27	: 0.13 g (typ.)

**Logic Diagram**

**1/2 TC4015B**



**Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
DC supply voltage	$V_{DD}$	$V_{SS} - 0.5 \sim V_{SS} + 20$	V
Input voltage	$V_{IN}$	$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
Output voltage	$V_{OUT}$	$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
DC input current	$I_{IN}$	$\pm 10$	mA
Power dissipation	$P_D$	300 (DIP)/180 (SOIC)	mW
Operating temperature range	$T_{opr}$	-40~85	°C
Storage temperature range	$T_{stg}$	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

**Operating Ranges ( $V_{SS} = 0$  V) (Note)**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
DC supply voltage	$V_{DD}$	—	3	—	18	V
Input voltage	$V_{IN}$	—	0	—	$V_{DD}$	V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .

## Static Electrical Characteristics (V<sub>SS</sub> = 0 V)

Characteristics	Sym- bol	Test Condition	V <sub>DD</sub> (V)	-40°C		25°C			85°C		Unit	
				Min	Max	Min	Typ.	Max	Min	Max		
High-level output voltage	V <sub>OH</sub>	I <sub>OUT</sub>   < 1 μA V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	4.95	—	4.95	5.00	—	4.95	—	V	
			10	9.95	—	9.95	10.00	—	9.95	—		
			15	14.95	—	14.95	15.00	—	14.95	—		
Low-level output voltage	V <sub>OL</sub>	I <sub>OUT</sub>   < 1 μA V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	—	0.05	—	0.00	0.05	—	0.05	V	
			10	—	0.05	—	0.00	0.05	—	0.05		
			15	—	0.05	—	0.00	0.05	—	0.05		
Output high current	I <sub>OH</sub>	V <sub>OH</sub> = 4.6 V V <sub>OH</sub> = 2.5 V V <sub>OH</sub> = 9.5 V V <sub>OH</sub> = 13.5 V V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	-0.61	—	-0.51	-1.0	—	-0.42	—	mA	
			5	-2.50	—	-2.10	-4.0	—	-1.70	—		
			10	-1.50	—	-1.30	-2.2	—	-1.10	—		
			15	-4.00	—	-3.40	-9.0	—	-2.80	—		
Output low current	I <sub>OL</sub>	V <sub>OL</sub> = 0.4 V V <sub>OL</sub> = 0.5 V V <sub>OL</sub> = 1.5 V V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	0.61	—	0.51	1.2	—	0.42	—	mA	
			10	1.50	—	1.30	3.2	—	1.10	—		
			15	4.00	—	3.40	12.0	—	2.80	—		
Input high voltage	V <sub>IH</sub>	V <sub>OUT</sub> = 0.5 V, 4.5 V V <sub>OUT</sub> = 1.0 V, 9.0 V V <sub>OUT</sub> = 1.5 V, 13.5 V  I <sub>OUT</sub>   < 1 μA	5	3.5	—	3.5	2.75	—	3.5	—	V	
			10	7.0	—	7.0	5.50	—	7.0	—		
			15	11.0	—	11.0	8.25	—	11.0	—		
Input low voltage	V <sub>IL</sub>	V <sub>OUT</sub> = 0.5 V, 4.5 V V <sub>OUT</sub> = 1.0 V, 9.0 V V <sub>OUT</sub> = 1.5 V, 13.5 V  I <sub>OUT</sub>   < 1 μA	5	—	1.5	—	2.25	1.5	—	1.5	V	
			10	—	3.0	—	4.50	3.0	—	3.0		
			15	—	4.0	—	6.75	4.0	—	4.0		
Input current	"H" level	I <sub>IH</sub>	V <sub>IH</sub> = 18 V	18	—	0.1	—	10 <sup>-5</sup>	0.1	—	1.0	μA
	"L" level	I <sub>IL</sub>	V <sub>IL</sub> = 0 V	18	—	-0.1	—	-10 <sup>-5</sup>	-0.1	—	-1.0	
Quiescent supply current	I <sub>DD</sub>	V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub> (Note)	5	—	5	—	0.005	5	—	150	μA	
			10	—	10	—	0.010	10	—	300		
			15	—	20	—	0.015	20	—	600		

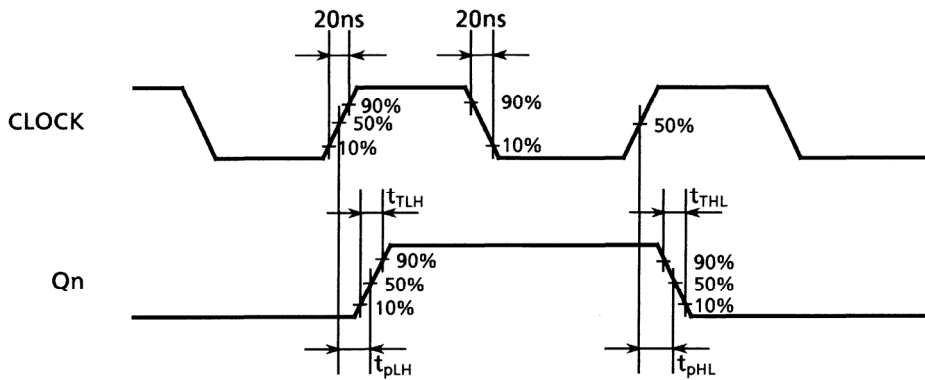
Note: All valid input combinations.

## Dynamic Electrical Characteristics (Ta = 25°C, VSS = 0 V, CL = 50 pF)

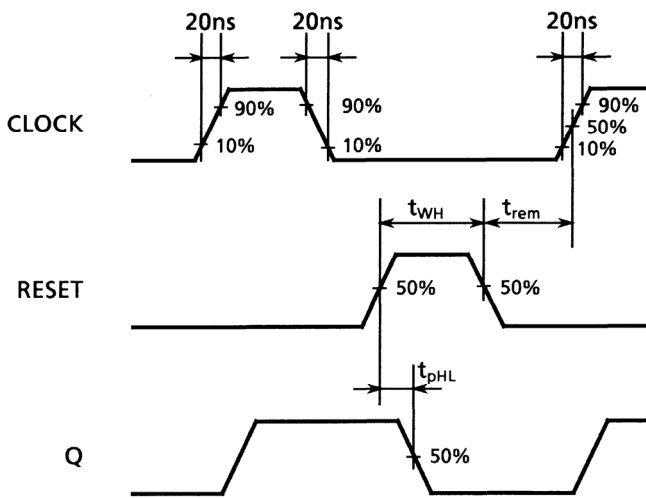
Characteristics	Symbol	Test Condition	VDD (V)	Min	Typ.	Max	Unit
Output transition time (low to high)	t <sub>TLH</sub>	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Output transition time (high to low)	t <sub>THL</sub>	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Propagation delay time (CLOCK-Q)	t <sub>pLH</sub> t <sub>pHL</sub>	—	5	—	130	320	ns
			10	—	60	160	
			15	—	50	120	
Propagation delay time (RESET-Q)	t <sub>pHL</sub>	—	5	—	90	400	ns
			10	—	45	200	
			15	—	40	160	
Max clock frequency	f <sub>CL</sub>	—	5	3.0	8	—	MHz
			10	6.0	17	—	
			15	8.5	20	—	
Min clock pulse width	t <sub>w</sub>	—	5	—	35	180	ns
			10	—	25	80	
			15	—	20	50	
Min pulse width (RESET)	t <sub>WH</sub>	—	5	—	50	200	ns
			10	—	25	80	
			15	—	20	60	
Min set-up time (DATA-CLOCK)	t <sub>SU</sub>	—	5	—	8	70	ns
			10	—	4	40	
			15	—	0	30	
Min hold time (DATA-CLOCK)	t <sub>H</sub>	—	5	—	6	60	ns
			10	—	5	30	
			15	—	4	20	
Min removal time (RESET-CLOCK)	t <sub>rem</sub>	—	5	—	0	80	ns
			10	—	0	30	
			15	—	0	20	
Max clock input rise time Max clock input fall time	t <sub>rCL</sub> t <sub>fCL</sub>	—	5	No limit			μs
			10				
			15				
Input capacitance	C <sub>IN</sub>	—	—	5	7.5	pF	

**Waveforms for Measurement of Dynamic Characteristics**

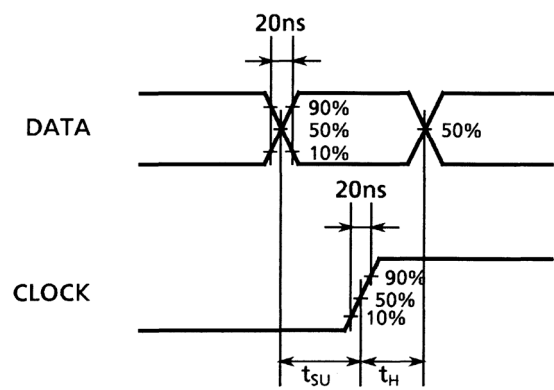
**Waveform 1**



**Waveform 2**



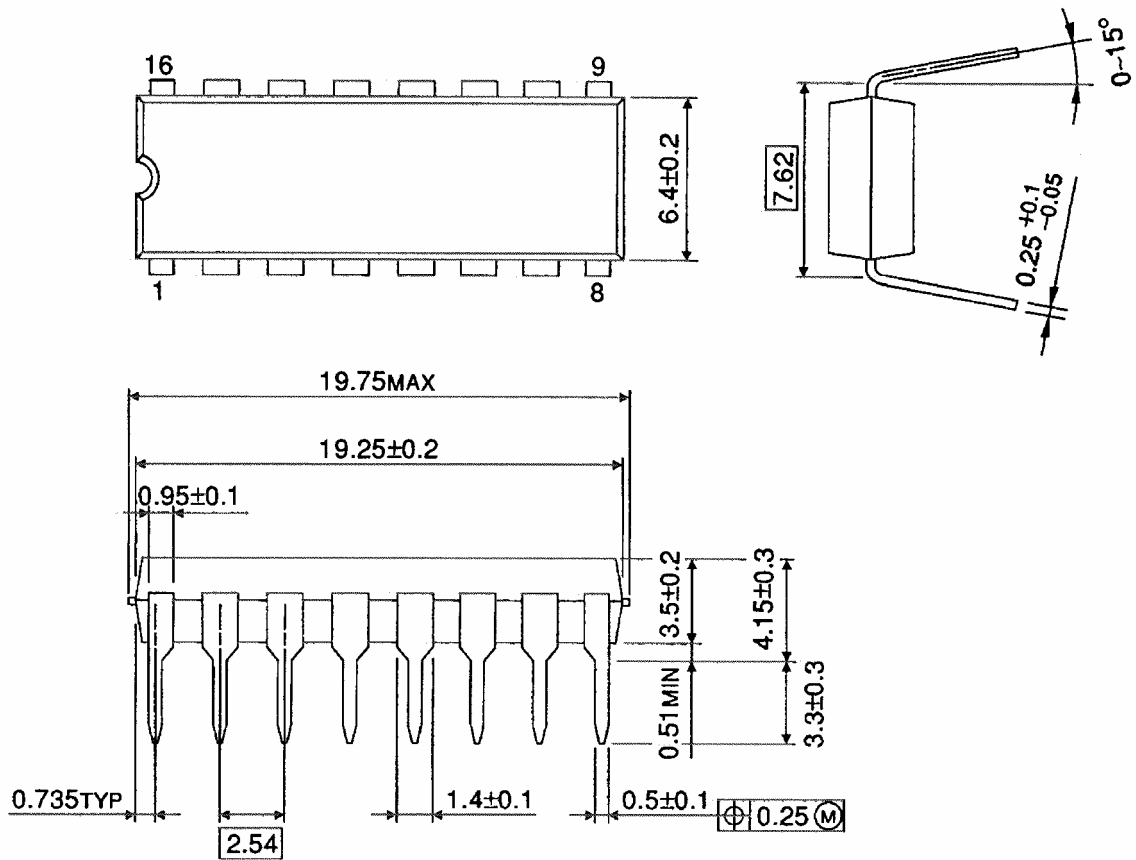
**Waveform 3**



## Package Dimensions

DIP16-P-300-2.54A

Unit : mm



Weight: 1.00 g (typ.)

## Package Dimensions

SOP16-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

Package Dimensions (Note)

SOL16-P-150-1.27

Unit : mm



Note: This package is not available in Japan.

Weight: 0.13 g (typ.)



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20070701-EN GENERAL

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